



CCIC Southern Electronic Product Testing (Shenzhen) Co., Ltd.

CERTIFICATE OF EMC

CERTIFICATE NO.: SET2015-01426

Product: Car expansion board
Model: BL2000-CEB-V* (*=2-2.99, indicate the different customer or/and Software function number)
Applicant: ShenYang Bluelight Automatic Technology Co., Ltd.
Address: No. 37 Shiji Road, Hunnan New District, Shenyang, China

This is to certify that, on the basis of the tests undertaken as per Report No. **SET2015-01426**, the submitted sample of the above item complies with:

EN61000-6-4:2007+A1:2011
EN61000-6-2:2005

and fulfils testing requirement of the EMC directive 2004/108/EC



Signed for and on behalf of

CCIC Southern Electronic Product Testing (Shenzhen) Co., Ltd.

Wu Li An, Vice Director



Date of Issue: Feb. 06, 2015

CCIC Southern Electronic Product Testing (Shenzhen) Co., Ltd.

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Shenzhen, China (pc: 518055)

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EMC TEST REPORT

- : SET2015-01426
- : Car expansion board
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- : Nanshan District, Shenzhen, Guangdong, China
- : 86 755 26627338 Fax 86 755 26627238



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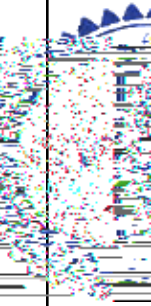
查询码: 6PA7ZR5b



Report

Product.....: Car expansion board
Model No.: BL2000-CEB-V* (*=2-2.99, indicate the different customer or/and Software function number)
Brand Name.....: /
Applicant.....: ShenYang Bluelight Automatic Technology Co., Ltd.
Applicant Address.....: No. 37 Shiji Road, Hunnan New District, Shenyang, China
Manufacturer.....: ShenYang Bluelight Automatic Technology Co., Ltd.
Manufacturer Address.....: No. 37 Shiji Road, Hunnan New District, Shenyang, China
Test Standards.....: **EN61000-6-4:2007+A1:2011** Electromagnetic compatibility (EMC) -- Part 6-4: Generic standards - Emission standard for industrial environments
EN61000-6-2:2005 Electromagnetic compatibility (EMC) -- Part 6-2: Generic standards - Immunity for industrial environments
Test Result.....: Pass
Tested by: *Chen Weichang* Feb. 06. 2015
Signature, DaTj Tc.14 -1.321363(Tj Tc. 14.695 .22 TD
Zhu Qi
Wu Lian







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1 General Information

1.1 Description of EUT

Car expansion board

BL2000-CEB-V2.0

/

/

Input: 24V DC

/

NOTE:

1. For more detailed features description about the EUT, please refer to User's Manual.
2. Application model is BL2000-CEB-V* (*=2-2.99, indicate the different customer or/and Software function number). Models differences do not affect the performance of EMC. All tests were performed on Model BL2000-CEB-V2.0 and results represented other models.
3. The highest frequency of the internal source of the EUT is below 108 MHz, so the radiated emission measurement shall be made up to 1GHz.

1.2 Objective

Perform ElectroMagnetic Interference (EMI) and ElectroMagnetic Susceptibility (EMS) tests for CE Marking.

2 Test Facilities and Configuration

2.1 Environmental Conditions

During the measurement the environmental conditions were within the listed ranges:

- Temperature: 15-35°C
- Humidity: 30-60 %
- Atmospheric pressure: 86-106 kPa

2.2 Measurement Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

- Uncertainty of Radiated Emission, $U_c = \pm 4.7\text{dB}$



2.3 Test Standards and Results

The EUT has been tested according to the following specifications:

EMISSION		
Standard	Test Type	Result
EN61000-6-4:2007+A1:2011	Radiated disturbance	PASS
IMMUNITY (EN61000-6-2:2005)		
Basic Standard	Test Type	Result
IEC 61000-4-2	Electrostatic discharge immunity	PASS
IEC 61000-4-3	Radiated, radio frequency electromagnetic field immunity	PASS
IEC 61000-4-4	Electrical fast transient/burst immunity	PASS
IEC 61000-4-5	Surge immunity	PASS
IEC 61000-4-6	Immunity to conducted disturbances induced by RF fields	PASS
IEC 61000-4-8	Power frequency magnetic field immunity	PASS



2.4 List of Equipments Used

Description	Manufacturer	Model No.	Calibration Date	Serial No.
Test Receiver	ROHDE&SCHWARZ	ESCI	Jun.10, 2015	A0902601
Broadband Ant.	ROHDE&SCHWARZ	VULB 09160	Jun.10, 2015	A0805560
Anechoic Chamber	Albatross	SAC-10MAC 19.6*11.8*8.55m	Jun.23, 2015	A0802520
Signal Generator	ROHDE&SCHWARZ	SMR27	Jun.10, 2015	A0304219
Signal Generator	ROHDE&SCHWARZ	SML02	Jun.10, 2015	A0304261
EMS Antenna	Amplifier Research	AR AT1080	Jun.10, 2015	A0304249
EMS Antenna	Amplifier Research	AR AT4002A	Jun.10, 2015	A0304250
Power Amplifier	Amplifier Research	150W1000	/	A0304247
Power Amplifier	Amplifier Research	AR 75A250M	/	A0304255
Power Amplifier	Amplifier Research	25S1g4AM1	/	A0304248
Capacitive clamp	ROHDE&SCHWARZ	F2301	/	A0304258
EFT Test System	HAEFELY	PEFT JUNIOR	May.22, 2015	A0103110
Surge Test System	EM TEST	VCS500M10	Jun.10, 2015	A0712509
	EM TEST	CNV503S9	Jun.10, 2015	A0712510
ESD Test System	EM TEST	ESD30C	Sep.24.2015	A0712513
Magnetic Field Tester	HAEFELY	MAG 100.1	Jun.10. 2015	A0103109

NOTE: Equipments above have been calibrated and are in the period of validation.

3 Emission Test

3.1 EUT Setup and Operating Conditions

The EUT was powered by 24V DC mains. The EUT was continuously operated during the test.

3.2 Radiated Disturbance Measurement

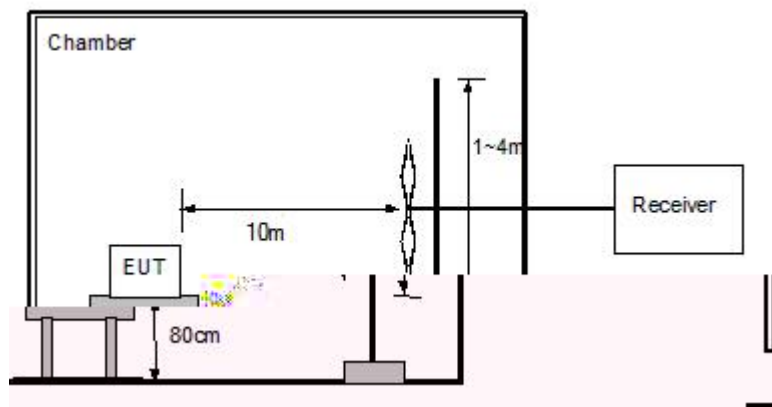
3.2.1 Limits of Radiated Disturbance

Frequency range (MHz)	Quasi peak limits(dB μ V/m), at 10m measurement distance
30 – 230	40
230 - 1000	47

Notes:

- (1) The lower limit shall apply at the transition frequency.
- (2) Additional provisions may be required for cases where interference occurs.

3.2.2 Test Setup

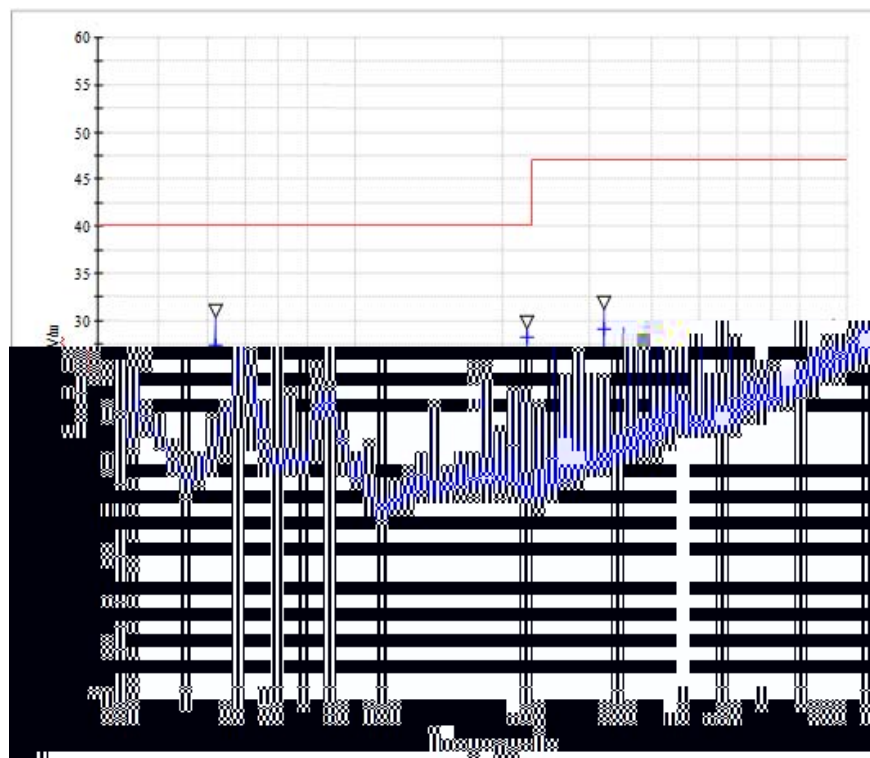




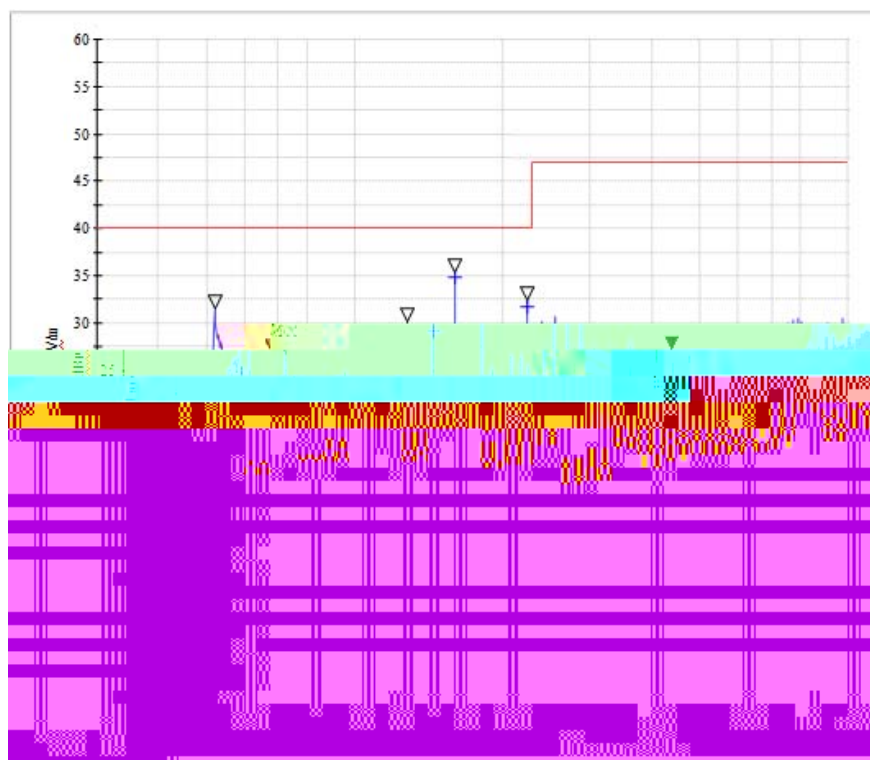
3.2.3 Test Result

No.	Frequency (MHz)	Antenna Polarization	Antenna Height (cm)	Table Angle (Degree)	QP Limits (dB μ V/m)	Emission Level (dB μ V/m)
1	52.080000	H	400	0	40	24.8
2	64.000000	H	400	0	40	27.8
3	127.960000	H	400	0	40	29.1
4	160.000000	H	400	0	40	34.8
5	224.000000	H	400	0	40	31.6
6	390.120000	H	400	0	40	24.2
7	31.960000	V	100	0	40	21.2
8	52.080000	V	100	0	40	27.4
9	75.840000	V	100	0	40	21.1
10	160.000000	V	100	0	40	21.3
11	224.000000	V	100	0	40	28.3
12	320.000000	V	100	0	40	29.1

1. Electromagnetic radiation disturbances, max peak detector, antenna polarization: Vertical



2. Electromagnetic radiation disturbances, max peak detector, antenna polarization: Horizontal



4 Immunity Test

4.1 EUT Setup and Operating Conditions

Same as 3.1.

4.2 Performance Criteria

Criterion A	The apparatus shall continue to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended.
Criterion B	The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended.
Criterion C	Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.

4.3 Electrostatic Discharge Immunity Test

4.3.1 Test Specification

Basic Standard:	IEC 61000-4-2
Discharge Impedance	330 / 150 pF
Discharge Voltage:	Air Discharge: 8 kV Contact Discharge: 4kV
Polarity:	Positive / Negative
Number of Discharge:	Minimum 20 times at each test point
Discharge Mode:	Single discharge
Discharge Period:	1-second minimum
Criterion:	B

4.3.2 Test Setup



EUT

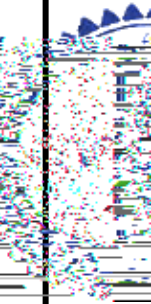
For the actual test configuration, please refer to Appendix II Photographs of the Test Configuration.

4.3.3 Test Result

Test Points	Discharge Level (kV)	Discharge Mode	Observation	Comply with Criterion
Screen	$\pm 2, 4, 6, 8$	Air	Note(1)	A
HCP	2, 4	Contact	Note(1)	A
VCP	2, 4	Contact	Note(1)	A

NOTE:

(1). The EUT continued to operate as intended. No degradation of performance was observed.



4.4.3 Test Result

Frequency	Polarity	Azimuth	Field Strength (V/m)	Observation	Comply with Criterion
80-1000 MHz	V&H	0,90, 80, 270	10	Note(1)	A
1.4-2.0GHz	V&H	0,90, 80, 270	3	Note(1)	A
2.0-2.7GHz	V&H	0,90, 80, 270	1	Note(1)	A

NOTE:

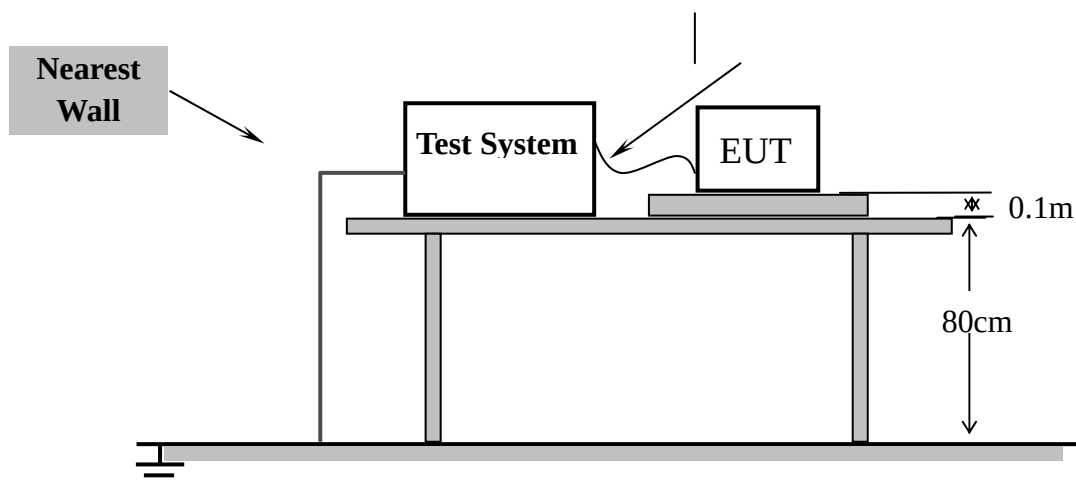
(1). The EUT continued to operate as intended. No degradation of performance was observed.

4.5 Electrical Fast Transient/Burst Immunity Test

4.5.1 Test Specification

Basic Standard:	IEC 61000-4-4
Test Voltage:	DC. Power port: 2 kV
Polarity:	Positive/Negative
Impulse Frequency:	5kHz
Impulse wave shape:	5/50ns
Burst Duration:	15ms
Burst Period:	300ms
Test Duration:	Not less than 1 min.
Criterion:	B

4.5.2 Test Setup



For the actual test configuration, please refer to Appendix II Photographs of the Test Configuration.

4.5.3 Test Result

Test Point	Polarity	Test Level (kV)	Observation	Comply with Criterion
DC. power	+/-	2	Note (1)	A

NOTE:

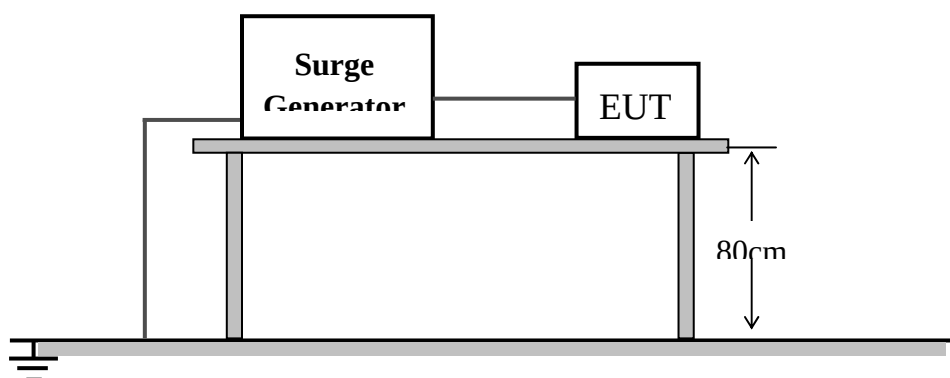
(1). The EUT continued to operate as intended. No degradation of performance was observed.

4.6 Surge Immunity Test

4.6.1 Test Specification

Basic Standard:	IEC 61000-4-5
Waveform:	Voltage 1.2/50 μ s; Current 8/20 μ s
Test Voltage:	DC power port: line to line 0.5 kV, line to earth 0.5 kV
Polarity:	Positive/Negative
Repetition Rate:	60sec
Times:	5 time/each condition.
Criterion:	B

4.6.2 Test Setup



4.6.3 Test Result

Coupling Line	Polarity	Voltage (kV)	Observation	Comply with Criterion
DC power, Line-Line	+/-	0.5	Note (1)	B

NOTE:

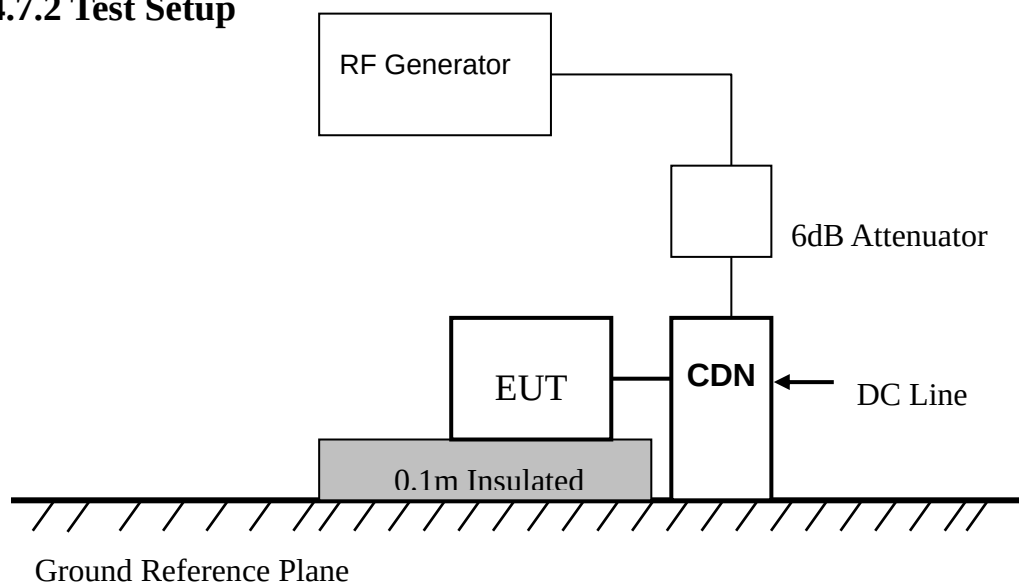
(1). The EUT continued to operate as intended. No degradation of performance was observed.

4.7 Immunity to Conducted Disturbances Induced by RF Fields

4.7.1 Test Specification

Basic Standard:	IEC 61000-4-6
Frequency Range:	0.15 MHz – 80 MHz
Field Strength:	10V
Modulation:	1 kHz Sine Wave, 80%, AM Modulation
Frequency Step:	1% of fundamental
Coupled Cable:	DC. power line
Coupling Device:	Capacitive clamp
Criterion:	A

4.7.2 Test Setup



4.7.3 Test Result

Test Point	Frequency	Field Strength (Vrms)	Observation	Comply with criterion
DC Power Line	0.15 – 80 MHz	10	Note(1)	A

NOTE:

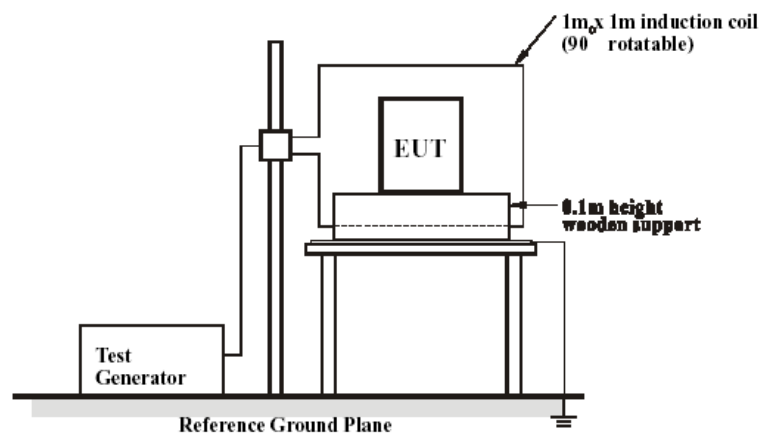
(1). The EUT continued to operate as intended. No degradation of performance was observed.

4.8 Power Frequency Magnetic Field Immunity Test

4.8.1 Test Specification

Basic Standard:	IEC 61000-4-8
Frequency Range:	50Hz
Field Strength:	30A/m
Observation Time:	2 minute
Inductance Coil:	Rectangular type, 1m 1m
Criterion:	A

4.8.2 Test Setup



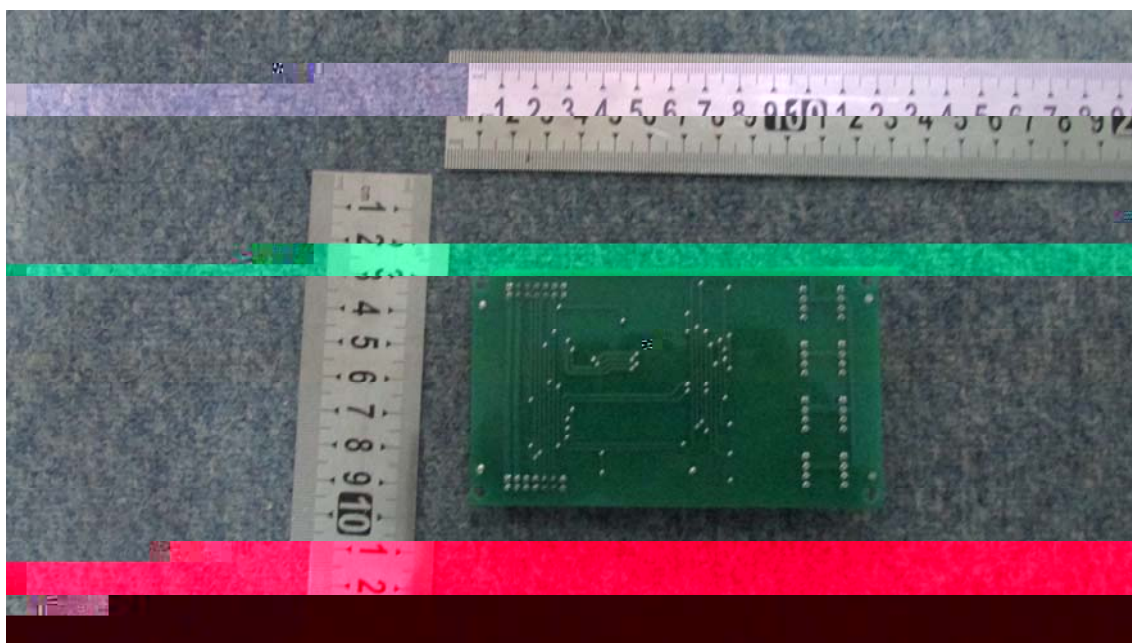
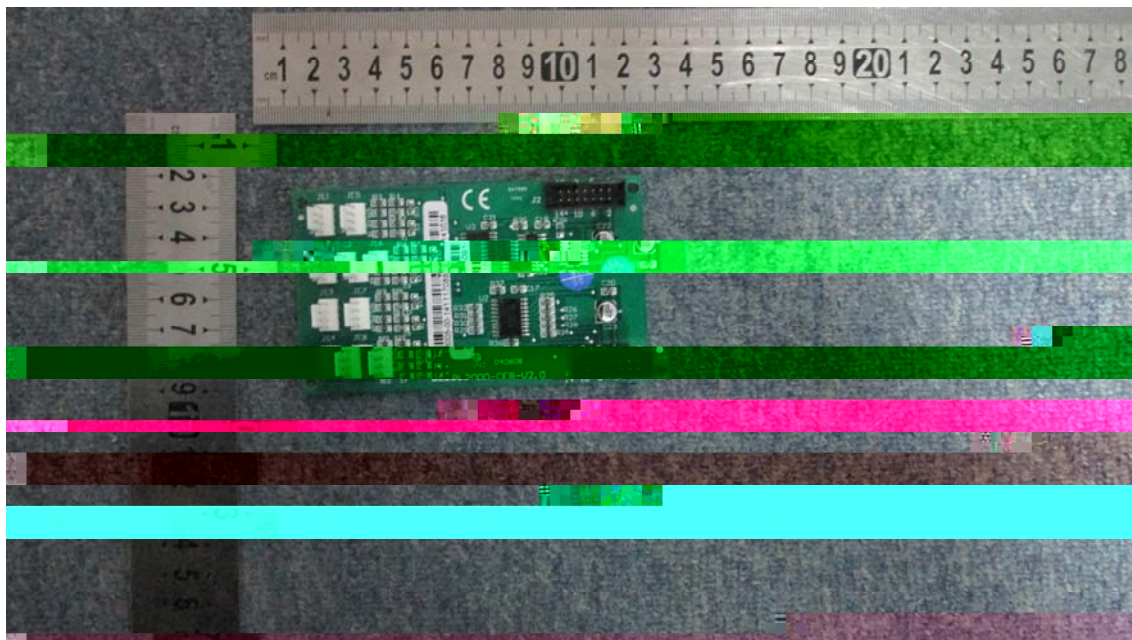
4.8.3 Test Result

Direction	Field Strength(A/m)	Observation	Comply with Criterion
X	30	Note(1)	A
Y	30	Note(1)	A
Z	30	Note(1)	A

NOTE:

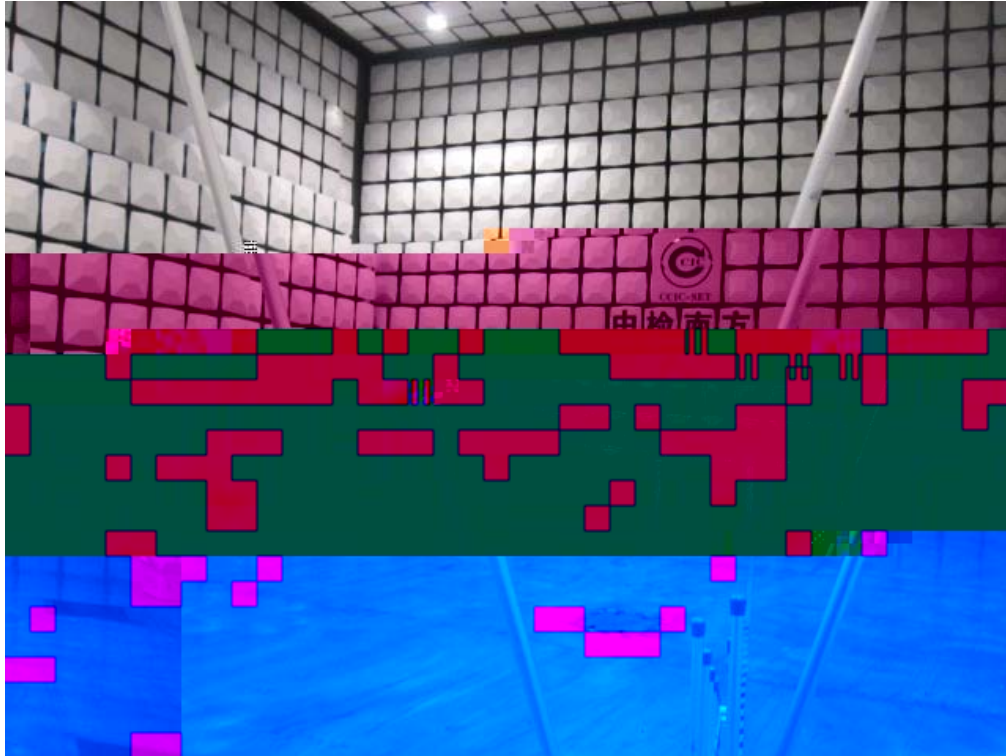
(1). The EUT continued to operate as intended. No degradation of performance was observed

Appendix I Photographs of the EUT

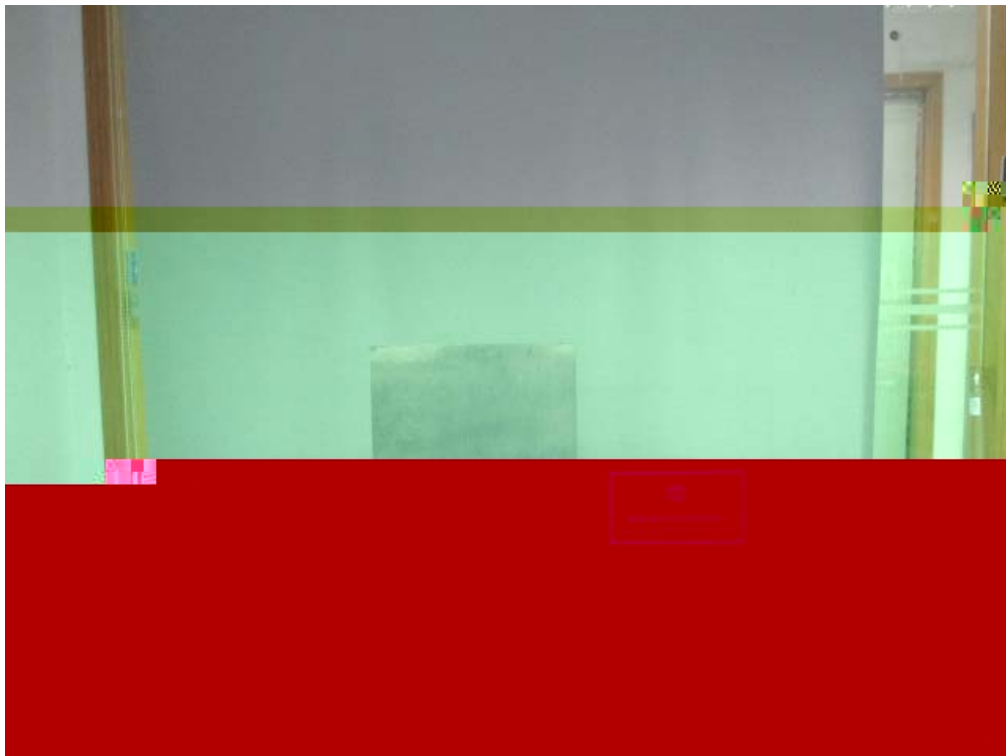


Appendix II Photographs of EMC Test Configuration

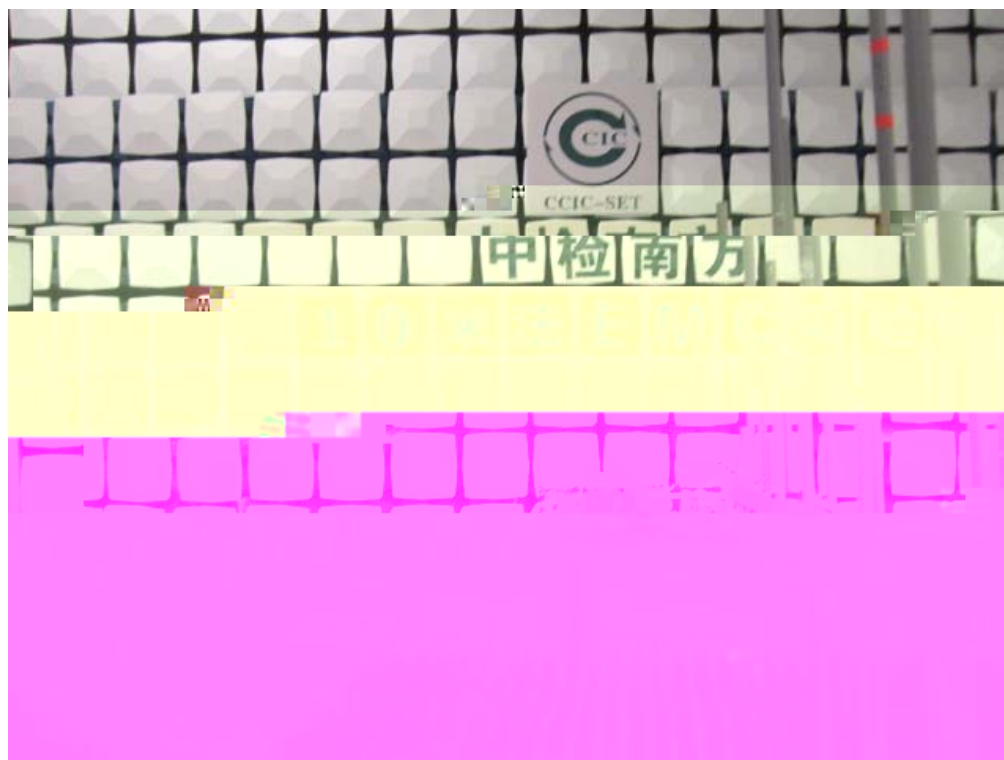
1. Radiated Field Strength Measurement



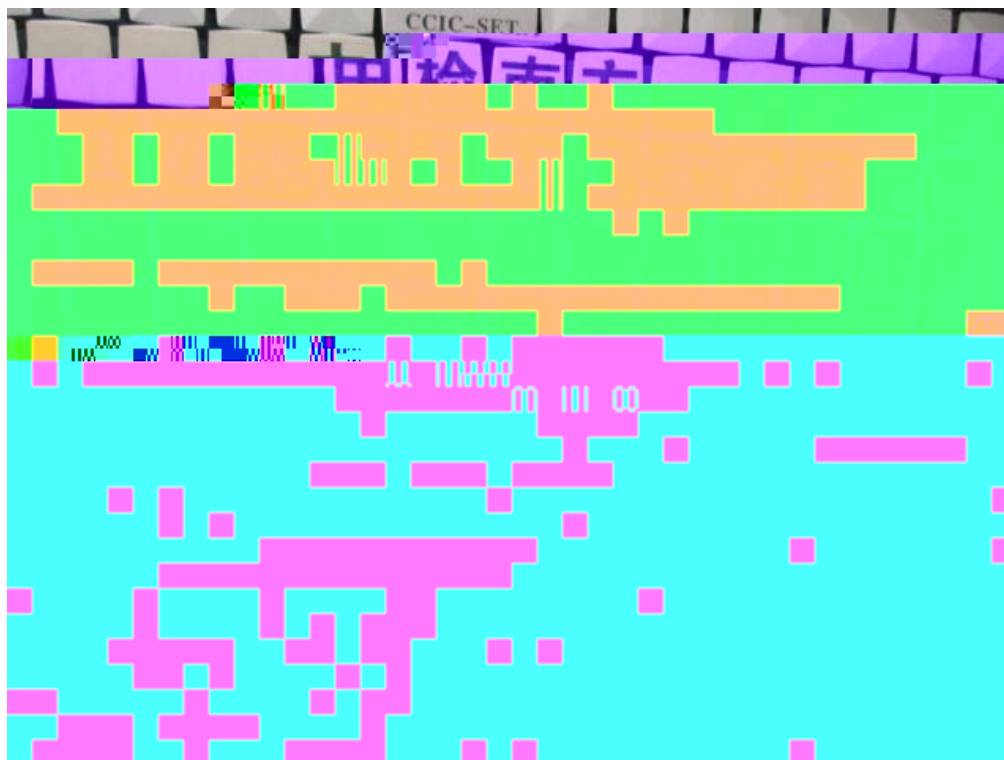
2. Electrostatic Discharge Immunity Test



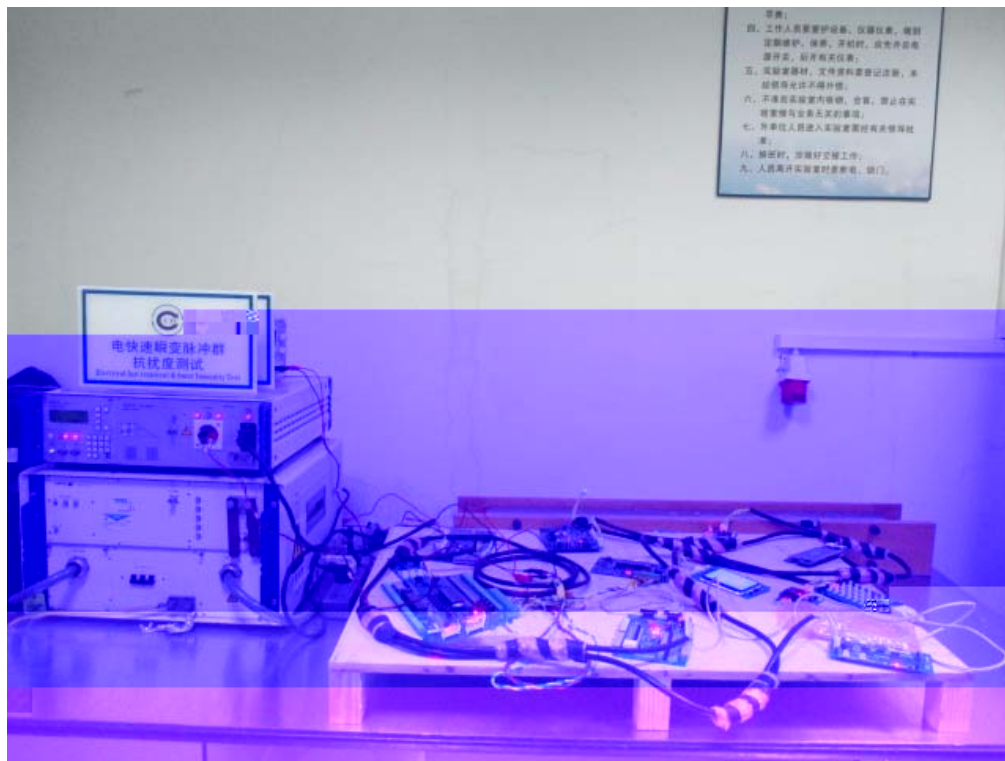
3. Radiated, Radio Frequency Electromagnetic Field Immunity Test (below 1GHz)



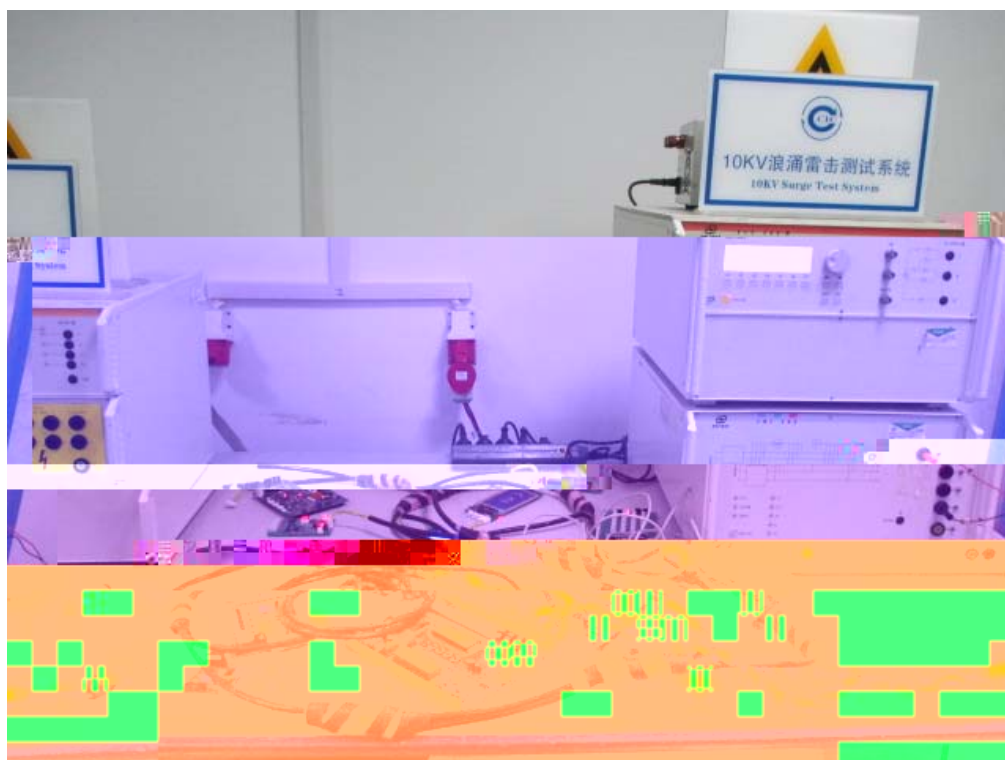
4. Radiated, Radio Frequency Electromagnetic Field Immunity Test (above 1GHz)



5. Electrical Fast Transient/Burst Immunity Test



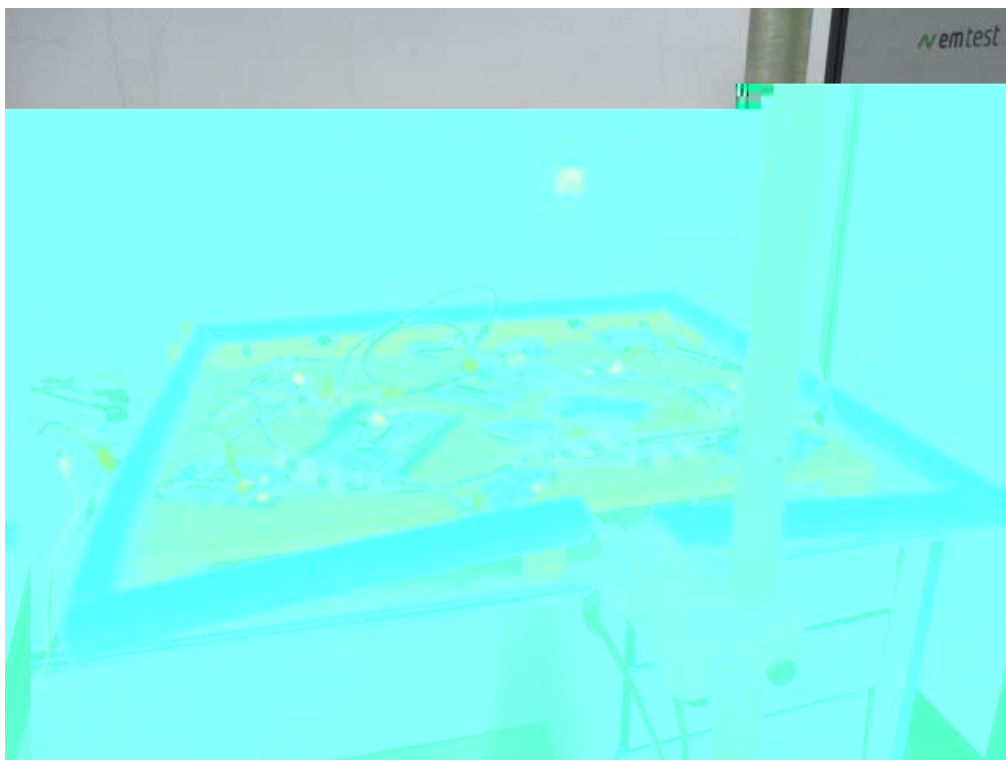
6. Surge Immunity Test



7. Immunity to Conducted Disturbances Induced by RF Fields



8. Power Frequency magnetic Field Immunity





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